

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF: Ryu OGIWARA

SERIAL NO: NEW APPLICATION

GAU:

FILED: HEREWITH

EXAMINER:

FOR: FERROELECTRIC MEMORY AND METHOD OF TESTING THE SAME

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

COMMISSIONER FOR PATENTS
ALEXANDRIA, VIRGINIA 22313

SIR:

Applicant(s) wish to disclose the following information.

REFERENCES

- ☒ The applicant(s) wish to make of record the references listed on the attached form PTO-1449. Copies of the listed references are attached, where required, as are either statements of relevancy or any readily available English translations of pertinent portions of any non-English language references.
- ☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

RELATED CASES

- ☐ Attached is a list of applicant's pending application(s) or issued patent(s) which may be related to the present application. A copy of the patent(s), together with a copy of the claims and drawings of the pending application(s) is attached along with PTO 1449.
- ☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

CERTIFICATION

- ☐ Each item of information contained in this information disclosure statement was first cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.
- ☐ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

DEPOSIT ACCOUNT

- ☒ Please charge any additional fees for the papers being filed herewith and for which no check or credit card payment is enclosed herewith, or credit any overpayment to deposit account number 15-0030. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND,
MAIER & NEUSTADT, P.C.


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C. Irvin McClelland
Registration Number 21,124

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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FOR: FERROELECTRIC MEMORY AND METHOD OF TESTING THE SAME

STATEMENT OF RELEVANCY

Reference AA (5,661,730) on Form PTO-1449:

This reference describes a same state and opposite state diagnostic test for Ferroelectric memories.

Reference AB (5,991,189) on Form PTO-1449:

This reference describes a Test Circuit for short retention time cell.

Reference AC (5,822,237) on Form PTO-1449:

This reference describes a Ref. Voltage supply method.

Reference AO (2000-268599) on Form PTO-1449:

This reference describes a High-Speed Test method for un-selected cell to be disturbed by coupling noise.

Reference AW on Form PTO-1449:

In this reference Fig 3 shows retained polarization as a function of delay times for applied amplitudes of 7.7, 5.0 and 3.5V. This means that 100msec is necessary to wait to measure depolarized cells.

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 245669US2S		SERIAL NO. NEW APPLICATION	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Ryu OGIWARA			
				FILING DATE HEREWITH		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
	AA	5,661,730	08/26/97	Sanjay MITRA, et al.			
	AB	5,991,189	11/23/99	Tohru MIWA			
	AC	5,822,237	10/13/98	Dennis R. WILSON, et al.			
	AD	5,903,492	05/11/99	Daisaburo TAKASHIMA			
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
	AO	2000-268599	09/29/00	Japan		X	
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW	Joseph M. BENEDETTO, et al., "Effects of operating conditions on the fast-decay component of the retained polarization in lead zirconate titanate thin films", JAPPL PHYS. 75 (1), January 1, 1994					
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner				Date Considered			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							